

Notice of References Cited

Application/Control No.

10/089,246

Applicant(s)/Patent Under
Reexamination
FEKETE ET AL.

Examiner

Urszula M Cegielnik

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,990,117	02-1991	Yonezawa, Shigeru	446/136
	B	US-6,217,405	04-2001	Burrows, Roger I.	446/135
	C	US-4,658,928	04-1987	Seo, Soo C.	180/168
	D	US-5,080,627	01-1992	Oriya et al.	446/444
	E	US-5,112,052	05-1992	Yamaura, Toranosuke	273/153R
	F	US-6,113,454	09-2000	Mitchell, Jerri	446/227
	G	US-6,099,379	08-2000	Eppley, Brad A.	446/392
	H	US-6,170,354	01-2001	Lee, Keung	446/460
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 3612938 A	05-1936	Japan		A63H 18/02
	O	JP 02084984 A	03-1990	Japan	SHIMIZU et al.	A63H 18/02
	P	GB 1127520 A	09-1968	Great Britain		A63H 18/10
	Q	GB 876054 A	08-1961	Great Britain		A63H 18/02
	R	DE 3409975 A1	09-1985	Germany	KOCH, STEFAN	A63H 18/10
	S	GB 784805 A	10-1957	Great Britain		A63H 18/10
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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